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Application/Contr No.	Applicant(s)/Patent under Reexaminati n	
10/727,349	GREATBATCH ET AL.	
Examiner	Art Unit	
Mark W. Bockelman	3766	

SEARCHED			
Class	Subclass	Date	Examiner
607	5,29	2-20-06	MB
320	103-104		
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INTERFERENCE SEARCHED			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
PG PJ	4-7-06	mB
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